# 3.3V / 5V ECL Quad D Flip-Flop with Set, Reset, and Differential Clock

The MC10/100EP131 is a Quad Master–slaved D flip–flop with common set and separate resets. The device is an expansion of the E131 with differential common clock and individual clock enables. With AC performance faster than the E131 device, the EP131 is ideal for applications requiring the fastest AC performance available.

Each flip-flop may be clocked separately by holding Common Clock ( $C_C$ ) LOW and  $\overline{C_C}$  HIGH, then using the differential Clock Enable inputs for clocking ( $C_{0-3}$ ,  $\overline{C_{0-3}}$ ).

Common clocking is achieved by holding the differential inputs  $C_{0-3}$  LOW and  $\overline{C}_{0-3}$  HIGH while using the differential Common Clock ( $C_C$ ) to clock all four flip–flops. When left floating open, any differential input will disable operation due to input pulldown resistors forcing an output default state.

Individual asynchronous resets  $(R_{0-3})$  and an asynchronous set (SET) are provided.

Data enters the master when both  $C_C$  and  $C_{0-3}$  are LOW, and transfers to the slave when either  $C_C$  or  $C_{0-3}$  (or both) go HIGH.

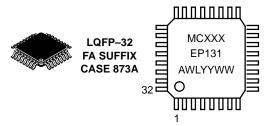
The 100 Series contains temperature compensation.

- 460 ps Typical Propagation Delay
- Maximum Frequency > 3 GHz Typical
- Differential Individual and Common Clocks
- Individual Asynchronous Resets
- Asynchronous Set
- PECL Mode Operating Range: V<sub>CC</sub> = 3.0 V to 5.5 V with V<sub>EE</sub> = 0 V
- NECL Mode Operating Range: V<sub>CC</sub> = 0 V with V<sub>EE</sub> = -3.0 V to -5.5 V
- Open Input Default State
- Safety Clamp on Inputs
- Q Output Will Default LOW with Inputs Open or at V<sub>EE</sub>



http://onsemi.com

MARKING DIAGRAM\*



XXX = 10 or 100

A = Assembly Location

WL = Wafer Lot

YY = Year

WW = Work Week

\*For additional information, see Application Note AND8002/D

#### ORDERING INFORMATION

Device	Package	Shipping
MC10EP131FA	LQFP-32	250 Units/Tray
MC10EP131FAR2	LQFP-32	2000 Tape & Reel
MC100EP131FA	LQFP-32	250 Units/Tray
MC100EP131FAR2	LQFP-32	2000 Tape & Reel

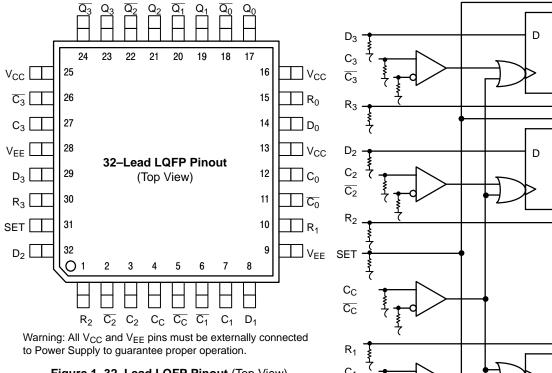


Figure 1. 32-Lead LQFP Pinout (Top View)

#### **PIN DESCRIPTION**

PIN	FUNCTION
D <sub>0-3</sub> *	ECL Data Inputs
$C_{0-3}^*, \overline{C_{0-3}}^*$	ECL Separate Clock Inputs
$C_C^*, \overline{C_C}^*$	ECL Common Clock Inputs
R <sub>0-3</sub> *	ECL Asynchronous Reset
SET*	ECL Asynchronous Set
$Q_{0-3}, \overline{Q_{0-3}}$	ECL Data Outputs
V <sub>CC</sub>	Positive Supply
V <sub>EE</sub>	Negative Supply

<sup>\*</sup> Pins will default LOW when left open.

 $C_1$  $Q_1$  $C_1$  $Q_1$  $C_0$  $\overline{\mathsf{Q}_0}$  $\overline{C_0}$  ${\sf Q}_0$ S  $\mathsf{V}_{\mathsf{EE}}$ 

Q

Q

 $Q_3$ 

 $\overline{\mathsf{Q}_3}$ 

 $Q_2$ 

Figure 2. Logic Diagram

#### **ATTRIBUTES**

Characteris	stics	Value
Internal Input Pulldown Resistor		75 kΩ
Internal Input Pullup Resistor		N/A
ESD Protection	Human Body Model Machine Model Charged Device Model	> 2 kV > 100 V > 2 kV
Moisture Sensitivity (Note 1)		Level 2
Flammability Rating	Oxygen Index: 28 to 34	UL 94 V-0 @ 0.125 in
Transistor Count		935 Devices
Meets or exceeds JEDEC Spec EIA	JESD78 IC Latchup Test	

<sup>1.</sup> For additional information, see Application Note AND8003/D.

#### MAXIMUM RATINGS (Note 2)

Symbol	Parameter	Condition 1	Condition 2	Rating	Units
V <sub>CC</sub>	PECL Mode Power Supply	V <sub>EE</sub> = 0 V		6	V
V <sub>EE</sub>	NECL Mode Power Supply	V <sub>CC</sub> = 0 V		-6	V
Vi	PECL Mode Input Voltage NECL Mode Input Voltage	V <sub>EE</sub> = 0 V V <sub>CC</sub> = 0 V	$V_{I} \leq V_{CC}$ $V_{I} \geq V_{EE}$	6 –6	V V
l <sub>out</sub>	Output Current	Continuous Surge		50 100	mA mA
I <sub>BB</sub>	V <sub>BB</sub> Sink/Source			± 0.5	mA
T <sub>A</sub>	Operating Temperature Range			-40 to +85	°C
T <sub>stg</sub>	Storage Temperature Range			-65 to +150	°C
$\theta_{JA}$	Thermal Resistance (Junction-to-Ambient)	0 LFPM 500 LFPM	32 LQFP 32 LQFP	80 55	°C/W
$\theta_{\text{JC}}$	Thermal Resistance (Junction-to-Case)	std bd	32 LQFP	12 to 17	°C/W
T <sub>sol</sub>	Wave Solder	> 2 to 3 sec @ 248°C		265	°C

<sup>2.</sup> Maximum Ratings are those values beyond which device damage may occur.

#### 10EP DC CHARACTERISTICS, PECL $V_{CC} = 3.3 \text{ V}$ , $V_{EE} = 0 \text{ V}$ (Note 3)

			–40°C		25°C						
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
I <sub>EE</sub>	Power Supply Current	70	95	120	70	95	120	70	95	120	mA
V <sub>OH</sub>	Output HIGH Voltage (Note 4)	2165	2290	2415	2230	2355	2480	2290	2415	2540	mV
$V_{OL}$	Output LOW Voltage (Note 4)	1365	1490	1615	1430	1555	1680	1490	1615	1740	mV
V <sub>IH</sub>	Input HIGH Voltage (Single–Ended)	2090		2415	2155		2480	2215		2540	mV
V <sub>IL</sub>	Input LOW Voltage (Single-Ended)	1365		1690	1460		1755	1490		1815	mV
V <sub>IHCMR</sub>	Input HIGH Voltage Common Mode Range (Differential) (Note 5)	2.0		3.3	2.0		3.3	2.0		3.3	V
I <sub>IH</sub>	Input HIGH Current			150			150			150	μΑ
I <sub>IL</sub>	Input LOW Current	0.5			0.5			0.5			μΑ

NOTE: EP circuits are designed to meet the DC specifications shown in the above table after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse airflow greater than 500 lfpm is maintained.

- 3. Input and output parameters vary 1:1 with  $V_{CC}$ .  $V_{EE}$  can vary +0.3 V to -2.2 V.
- 4. All loading with 50  $\Omega$  to V<sub>CC</sub>-2.0 volts.
- 5. V<sub>IHCMR</sub> min varies 1:1 with V<sub>EE</sub>, V<sub>IHCMR</sub> max varies 1:1 with V<sub>CC</sub>. The V<sub>IHCMR</sub> range is referenced to the most positive side of the differential input signal.

# 10EP DC CHARACTERISTICS, PECL $V_{CC} = 5.0 \text{ V}$ , $V_{EE} = 0 \text{ V}$ (Note 6)

		-40°C				25°C		85°C			
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
I <sub>EE</sub>	Power Supply Current	70	95	120	70	95	120	70	95	120	mA
V <sub>OH</sub>	Output HIGH Voltage (Note 7)	3865	3990	4115	3930	4055	4180	3990	4115	4240	mV
V <sub>OL</sub>	Output LOW Voltage (Note 7)	3065	3190	3315	3130	3255	3380	3190	3315	3440	mV
V <sub>IH</sub>	Input HIGH Voltage (Single-Ended)	3790		4115	3855		4180	3915		4240	mV
$V_{IL}$	Input LOW Voltage (Single–Ended)	3065		3390	3130		3455	3190		3515	mV
V <sub>IHCMR</sub>	Input HIGH Voltage Common Mode Range (Differential) (Note 8)	2.0		5.0	2.0		5.0	2.0		5.0	V
I <sub>IH</sub>	Input HIGH Current			150			150			150	μΑ
I <sub>IL</sub>	Input LOW Current	0.5			0.5			0.5			μΑ

NOTE: EP circuits are designed to meet the DC specifications shown in the above table after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse airflow greater than 500 lfpm is maintained.

- 6. Input and output parameters vary 1:1 with  $V_{CC}$ .  $V_{EE}$  can vary +2.0 V to -0.5 V.
- 7. All loading with 50  $\Omega$  to V<sub>CC</sub>–2.0 volts.
- 8. V<sub>IHCMR</sub> min varies 1:1 with V<sub>EE</sub>, V<sub>IHCMR</sub> max varies 1:1 with V<sub>CC</sub>. The V<sub>IHCMR</sub> range is referenced to the most positive side of the differential input signal.

10EP DC CHARACTERISTICS, NECL  $V_{CC} = 0 \text{ V}$ ,  $V_{EE} = -5.5 \text{ V}$  to -3.0 V (Note 9)

		−40°C			25°C						
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
I <sub>EE</sub>	Power Supply Current	70	95	120	70	95	120	70	95	120	mA
V <sub>OH</sub>	Output HIGH Voltage (Note 10)	-1135	-1010	-885	-1070	-945	-820	-1010	-885	-760	mV
V <sub>OL</sub>	Output LOW Voltage (Note 10)	-1935	-1810	-1685	-1870	-1745	-1620	-1810	-1685	-1560	mV
V <sub>IH</sub>	Input HIGH Voltage (Single-Ended)	-1210		-885	-1145		-820	-1085		-760	mV
V <sub>IL</sub>	Input LOW Voltage (Single-Ended)	-1935		-1610	-1870		-1545	-1810		-1485	mV
V <sub>IHCMR</sub>	Input HIGH Voltage Common Mode Range (Differential) (Note 11)	V <sub>EE</sub>	+2.0	0.0	V <sub>EE</sub>	+2.0	0.0	V <sub>EE</sub>	+2.0	0.0	V
I <sub>IH</sub>	Input HIGH Current			150			150			150	μΑ
I <sub>IL</sub>	Input LOW Current	0.5			0.5			0.5			μΑ

NOTE: EP circuits are designed to meet the DC specifications shown in the above table after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse airflow greater than 500 lfpm is maintained.

# 100EP DC CHARACTERISTICS, PECL $V_{CC} = 3.3 \text{ V}$ , $V_{EE} = 0 \text{ V}$ (Note 12)

			–40°C			25°C			85°C		
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
I <sub>EE</sub>	Power Supply Current	70	95	120	75	97	120	80	105	130	mA
V <sub>OH</sub>	Output HIGH Voltage (Note 13)	2155	2280	2405	2155	2280	2405	2155	2280	2405	mV
$V_{OL}$	Output LOW Voltage (Note 13)	1355	1480	1605	1355	1480	1605	1355	1480	1605	mV
$V_{IH}$	Input HIGH Voltage (Single-Ended)	2075		2420	2075		2420	2075		2420	mV
$V_{IL}$	Input LOW Voltage (Single-Ended)	1355		1675	1355		1675	1355		1675	mV
V <sub>IHCMR</sub>	Input HIGH Voltage Common Mode Range (Differential) (Note 14)	2.0		3.3	2.0		3.3	2.0		3.3	V
I <sub>IH</sub>	Input HIGH Current			150			150			150	μΑ
I <sub>IL</sub>	Input LOW Current	0.5			0.5			0.5			μΑ

NOTE: EP circuits are designed to meet the DC specifications shown in the above table after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse airflow greater than 500 lfpm is maintained.

# 100EP DC CHARACTERISTICS, PECL $V_{CC} = 5.0 \text{ V}$ , $V_{EE} = 0 \text{ V}$ (Note 15)

			–40°C		25°C						
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
I <sub>EE</sub>	Power Supply Current	70	95	120	75	97	120	80	105	130	mA
V <sub>OH</sub>	Output HIGH Voltage (Note 16)	3855	3980	4105	3855	3980	4105	3855	3980	4105	mV
V <sub>OL</sub>	Output LOW Voltage (Note 16)	3055	3180	3305	3055	3180	3305	3055	3180	3305	mV
$V_{IH}$	Input HIGH Voltage (Single-Ended)	3775		4120	3775		4120	3775		4120	mV
$V_{IL}$	Input LOW Voltage (Single-Ended)	3055		3375	3055		3375	3055		3375	mV
V <sub>IHCMR</sub>	Input HIGH Voltage Common Mode Range (Differential) (Note 17)	2.0		5.0	2.0		5.0	2.0		5.0	V
I <sub>IH</sub>	Input HIGH Current			150			150			150	μΑ
I <sub>IL</sub>	Input LOW Current	0.5			0.5			0.5			μΑ

NOTE: EP circuits are designed to meet the DC specifications shown in the above table after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse airflow greater than 500 lfpm is maintained.

<sup>9.</sup> Input and output parameters vary 1:1 with V<sub>CC</sub>.

<sup>10.</sup> All loading with 50  $\Omega$  to V<sub>CC</sub>-2.0 volts.

<sup>11.</sup> V<sub>IHCMR</sub> min varies 1:1 with V<sub>EE</sub>, V<sub>IHCMR</sub> max varies 1:1 with V<sub>CC</sub>. The V<sub>IHCMR</sub> range is referenced to the most positive side of the differential input signal.

<sup>12.</sup> Input and output parameters vary 1:1 with  $V_{CC}$ .  $V_{EE}$  can vary +0.3 V to -2.2 V.

<sup>13.</sup> All loading with 50  $\Omega$  to V<sub>CC</sub>-2.0 volts.

<sup>14.</sup> V<sub>IHCMR</sub> min varies 1:1 with  $V_{EE}$ ,  $V_{IHCMR}$  max varies 1:1 with  $V_{CC}$ . The  $V_{IHCMR}$  range is referenced to the most positive side of the differential input signal.

<sup>15.</sup> Input and output parameters vary 1:1 with  $V_{CC}$ .  $V_{EE}$  can vary +2.0 V to -0.5 V.

<sup>16.</sup> All loading with 50  $\Omega$  to  $V_{CC}$ =2.0 volts.

17.  $V_{IHCMR}$  min varies 1:1 with  $V_{EE}$ ,  $V_{IHCMR}$  max varies 1:1 with  $V_{CC}$ . The  $V_{IHCMR}$  range is referenced to the most positive side of the differential

100EP DC CHARACTERISTICS, NECL  $V_{CC}$  = 0 V,  $V_{EE}$  = -5.5 V to -3.0 V (Note 18)

		−40°C				25°C					
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
I <sub>EE</sub>	Power Supply Current	70	95	120	75	97	120	80	105	130	mA
V <sub>OH</sub>	Output HIGH Voltage (Note 19)	-1145	-1020	-895	-1145	-1020	-895	-1145	-1020	-895	mV
V <sub>OL</sub>	Output LOW Voltage (Note 19)	-1945	-1820	-1695	-1945	-1820	-1695	-1945	-1820	-1695	mV
V <sub>IH</sub>	Input HIGH Voltage (Single–Ended)	-1225		-880	-1225		-880	-1225		-880	mV
V <sub>IL</sub>	Input LOW Voltage (Single-Ended)	-1945		-1625	-1945		-1625	-1945		-1625	mV
V <sub>IHCMR</sub>	Input HIGH Voltage Common Mode Range (Differential) (Note 20)	V <sub>EE</sub>	+2.0	0.0	V <sub>EE</sub>	+2.0	0.0	V <sub>EE</sub>	+2.0	0.0	V
I <sub>IH</sub>	Input HIGH Current			150			150			150	μΑ
I <sub>IL</sub>	Input LOW Current	0.5			0.5			0.5			μΑ

NOTE: EP circuits are designed to meet the DC specifications shown in the above table after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse airflow greater than 500 lfpm is maintained.

# AC CHARACTERISTICS $V_{CC} = 0 \text{ V}$ ; $V_{EE} = -3.0 \text{ V}$ to -5.5 V or $V_{CC} = 3.0 \text{ V}$ to 5.5 V; $V_{EE} = 0 \text{ V}$ (Note 21)

			–40°C			25°C			85°C		
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
f <sub>max</sub>	Maximum Frequency (See Figure 3. Frequency vs. V <sub>OUTpp</sub> and JITTER)		> 3			> 3			> 3		GHz
t <sub>PLH</sub> , t <sub>PHL</sub>	$ \begin{array}{ccc} \text{Propagation Delay to} & & C_{0-3} \\ \text{Output Differential} & & C_{C} \\ & & R_{0-3} \\ & & \text{SET} \\ \end{array} $	320 320 320 300	450 450 430 430	520 520 520 550	380 400 380 380	460 500 480 460	580 600 580 580	450 450 450 400	560 560 560 530	650 650 700 650	ps
t <sub>RR</sub>	Set/R0–3 Recovery	290	210		290	210		350	280		ps
t <sub>S</sub>	Setup Time Hold Time	120	80		120	80		120	80		ps
t <sub>PW</sub>	Minimum Pulse Rate SET, R <sub>0-3</sub>	550	400		550	400		550	400		
t <sub>JITTER</sub>	Cycle–to–Cycle Jitter (See Figure 3. Frequency vs. V <sub>OUTpp</sub> and JITTER)		0.2	< 1		0.2	< 1		0.2	< 1	ps
t <sub>r</sub>	Output Rise/Fall Times Q, Q (20% – 80%)	110	180	250	125	200	275	150	230	300	ps

<sup>21.</sup> Measured using a 750 mV source, 50% duty cycle clock source. All loading with 50  $\Omega$  to V<sub>CC</sub>-2.0 V.

<sup>18.</sup> Input and output parameters vary 1:1 with V<sub>CC</sub>. 19. All loading with 50  $\Omega$  to V<sub>CC</sub>–2.0 volts.

<sup>20.</sup> V<sub>IHCMR</sub> min varies 1:1 with V<sub>EE</sub>, V<sub>IHCMR</sub> max varies 1:1 with V<sub>CC</sub>. The V<sub>IHCMR</sub> range is referenced to the most positive side of the differential input signal.

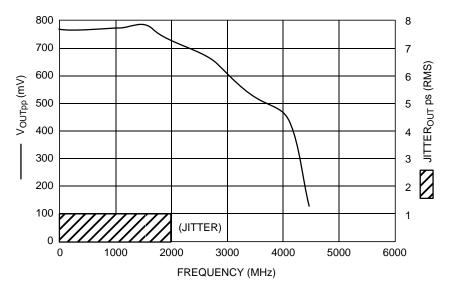


Figure 3. Frequency vs.  $V_{OUTpp}$  and JITTER

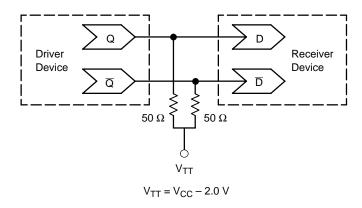


Figure 4. Typical Termination for Output Driver and Device Evaluation (See Application Note AND8020 – Termination of ECL Logic Devices.)

#### **Resource Reference of Application Notes**

AN1404 – ECLinPS Circuit Performance at Non–Standard V<sub>IH</sub> Levels

AN1405 – ECL Clock Distribution Techniques

AN1406 – Designing with PECL (ECL at +5.0 V)

AN1504 - Metastability and the ECLinPS Family

AN1568 - Interfacing Between LVDS and ECL

AN1650 - Using Wire-OR Ties in ECLinPS Designs

AN1672 – The ECL Translator Guide

AND8001 – Odd Number Counters Design

AND8002 - Marking and Date Codes

AND8009 – ECLinPS Plus Spice I/O Model Kit

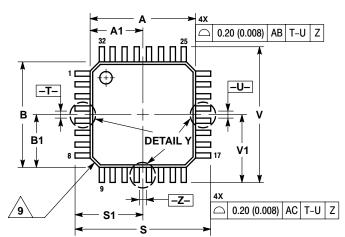
AND8020 – Termination of ECL Logic Devices

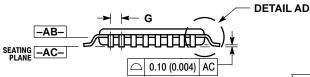
For an updated list of Application Notes, please see our website at http://onsemi.com.

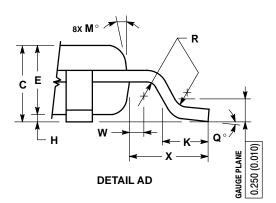
#### **PACKAGE DIMENSIONS**

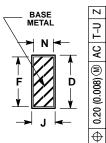
#### **LQFP FA SUFFIX**

32-LEAD PLASTIC PACKAGE CASE 873A-02 **ISSUE A** 

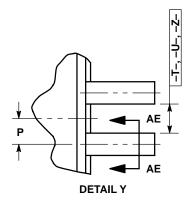








**SECTION AE-AE** 



- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- Y14.5M, 1982.

  2. CONTROLLING DIMENSION: MILLIMETER.

  3. DATUM PLANE -AB- IS LOCATED AT BOTTOM OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT
- THE BOTTOM OF THE PARTING LINE.

  4. DATUMS -T-, -U-, AND -Z- TO BE DETERMINED AT DATUM PLANE -AB-.

  5. DIMENSIONS S AND V TO BE DETERMINED AT CEATING DIAME.
- DIMENSIONS S AND V TO BE DETERMINED AT SEATING PLANE -AC-.
   DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION A AND B DO NOT INCLUDE MOLD PROTRUSION A LLOWABLE PROTRUSION IS 0.250 (0.010) PER SIDE. DIMENSIONS A AND B DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -AB-.
   DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. DAMBAR PROTRUSION SHALL NOT CAUSE THE D DIMENSION TO EXCEED 0.520 (0.220)
- 0.520 (0.020).

  8. MINIMUM SOLDER PLATE THICKNESS SHALL BE
- 0.0076 (0.0003).

  9. EXACT SHAPE OF EACH CORNER MAY VARY FROM DEPICTION.

		IETERS		HES		
DIM	MIN	MAX	MIN	MAX		
Α	7.000	BSC	0.276	BSC		
A1	3.500	BSC	0.138	BSC		
В	7.000	BSC	0.276	BSC		
B1	3.500	BSC	0.138	BSC		
С	1.400	1.600	0.055	0.063		
D	0.300	0.450	0.012	0.018		
E	1.350	1.450	0.053	0.057		
F	0.300	0.400	0.012	0.016		
G	0.800	BSC	0.031	BSC		
Н	0.050	0.150	0.002	0.006		
J	0.090	0.200	0.004	0.008		
K	0.500	0.700	0.020	0.028		
M	12°	REF	12°	REF		
N	0.090	0.160	0.004	0.006		
P	0.400	BSC	0.016	BSC		
Q	1°	5°	1°	5°		
R	0.150	0.250	0.006	0.010		
S	9.000	BSC	0.354 BSC			
S1	4.500	BSC	0.177 BSC			
٧	9.000	BSC	0.354 BSC			
V1	4.500	BSC	0.177 BSC			
W	0.200	REF	0.008 REF			
X	1.000	REF	0.039	REF		

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